



National Association for Proficiency Testing

A Non-Profit Organization Dedicated to Excellence in Metrology and Test Measurement

PRELIMINARY REPORT: NAPT-TEMP-201

This Preliminary Report documents the results for the ILC/PT listed below, covering all data presented to NAPT for evaluation by your organization. For tests with an established history, a Final Report will be issued after the 30 day review period expires. The Final Report will include a graphical representation of participants' values compared to the artifact mean and the values reported by the other participants.

Preliminary Results Reported To: **Digital Measurement Metrology Inc**
Attention: Raj Sharma
26 Automatic Road, Unit 4
Brampton, ON L6S 5N7

Date Of Preliminary Report: January 07, 2004
Date Of Participation in ILC/PT: January 05, 2004

ILC/PT NAME: NAPT-TEMP-201
Digital Temperature Indicator
Discipline: Electrical: Temperature/Measure
Artifact Type: Temperature
Manufacturer: Yokogawa
Model Number: Yokogawa
Serial Number: T3501QB025 648

Data analysis of your reported values indicates that your organization **performed 10 out of 10 measurements satisfactorily**. Please note that reference data is subject to change between issuance of Preliminary and Final Reports. If any data reported in this Preliminary Report is incorrect or if you would like to submit any revisions/corrections of your reported data, please contact us within 30 days.

All NAPT programs are conducted in accordance with ISO/IEC Guide 43-1 and ILAC G13:2000 requirements for proficiency testing providers. Please contact NAPT with any questions regarding this Preliminary Report.

Preliminary analysis of the data your organization submitted to NAPT is shown below. Reported values are compared against the reference value only. In the Final Report, your reported values will also be analyzed against the values reported by other participants enrolled in this ILC/PT.

Measurement Description	Reported Value Reference Value	Reported Uncertainty Reference Uncertainty	En	S/U
Temperature				
100 Deg F - 1) 100 Deg F	100.000 Deg F 100.080	0.653 0.627	0.09	S
500 Deg F - 2) 500 Deg F	500.000 Deg F 500.092	0.653 0.649	0.1	S
1000 Deg F - 3) 1000 Deg F	1000.000 Deg F 1000.148	0.828 0.666	0.14	S
1200 Deg F - 4) 1200 Deg F	1200.000 Deg F 1200.146	1 0.704	0.12	S
1400 Deg F - 5) 1400 Deg F	1400.000 Deg F 1400.137	0.653 0.713	0.14	S
1500 Deg F - 6) 1500 Deg F	1500.000 Deg F 1500.167	0.653 0.712	0.17	S
1700 Deg F - 7) 1700 Deg F	1700.000 Deg F 1700.228	1.201 0.714	0.16	S
1800 Deg F - 8) 1800 Deg F	1801.000 Deg F 1800.767	0.749 0.718	0.22	S
2000 Deg F - 9) 2000 Deg F	2000.000 Deg F 2000.786	0.828 0.802	0.68	S
2100 Deg F - 10) 2100 Deg F	2100.000 Deg F 2100.649	0.653 0.801	0.63	S

NOTES:

1. Values may be rounded. Rounding does not affect data analysis and is for reporting purposes only
2. All uncertainties are at (or normalized to) K=2 (coverage factor associated with a 2-sigma, 95%, normal distribution)
3. En = (participant's reported value - reference value) / SQRT (participant's reported uncertainty^2 + reference uncertainty^2)
4. S/U: S (Satisfactory) = participant's computed En is within range of ±1; U (Unsatisfactory) = participant's computed En is outside range of ±1